

计算全息法标定单光楔补偿检测系统误差

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Calibration of single optical wedge compensation test system error by computer generation hologram

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Abstract: As a testing method for large convex aspheric surface, the single optical wedge compensation test has good applicability, robustness and flexibility. However, various errors are coupled with one another during the test process and these errors are difficult to decouple. This affects the accuracy and reliability of the tests. To address this, a method is developed to calibrate the system error of single optical wedge test paths using a Computer Generation Hologram (CGH). We first analysed the source of system error in the optical path of a single optical wedge compensation test as well as the feasibility of using CGH for the calibration of an optical wedge compensation test system. In combination with engineering examples, a CGH was designed for optical wedge compensators with a diameter of 150 mm. Based on the analysis results, the calibration accuracy of the CGH was 1.98 nm RMS, and after calibration the test accuracy of single wedge compensation was 3.43 nm RMS, thereby meeting the high-precision test requirements of large convex aspheric mirrors. This shows that CGH can accurately calibrate the pose of single optical wedge compensators and the test system errors of optical paths. Thus we address the problems affecting error decoupling in test optical paths, and improve the accuracy and reliability of the single optical wedge compensation method. Meanwhile, using CGH calibration, the system errors of the test optical paths, Tap#2 and Tap#3, were 0.023 and 0.011 λ RMS, respectively.

Key words: computer generation hologram; optical test; diffraction; optical wedge

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计算全息法标定单光楔补偿检测系统误差

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摘要:单光楔补偿检测法具有良好的适用性、鲁棒性和灵活性,但是在检测光路中存在多种误差耦合,误差解耦困难,影响了单光楔补偿检测的精度和可信度。针对这一问题,本文提出一种计算全息法(Computer Generation Hologram, CGH)标定单光楔补偿检测光路系统误差的新方法。文中首先分析了单光楔补偿检测法系统误差的来源,并对 CGH 标定光楔补偿器的可行性进行了分析。结合工程实例,对口径为 150 mm 的单光楔补偿器设计了 CGH,经分析可得 CGH 的标定精度为 1.98 nm RMS, CGH 标定后单光楔补偿检测精度为 3.43 nm RMS,该精度能够满足大口径凸非球面反射镜的高精度检测要求。结果表明:CGH 可以准确标定单光楔补偿器的位姿和检测光路的系统误差,解决了检测光路中误差解耦困难的问题,提高了单光楔补偿检测的准确性和可靠性。使用 CGH 标定得到 Tap#2 和 Tap#3 的检测光路系统误差分别为 0.023 λ RMS 和 0.011 λ RMS。

关键词:计算全息;光学检测;衍射;光楔

中图分类号:O436.1

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1 Introduction

High-precision metrology of large aspheric surfaces, especially large convex aspheric mirrors, has always been a challenge in optical measurement^[1-2]. A method commonly used for effective testing large convex aspheric mirrors is the non-null test method^[3-4]. Compared with traditional non-null compensators, single optical wedges have unique advantages^[5-6]. Firstly, an optical wedge can produce astigmatism and coma that can be used to compensate for the main aberrations of the off-axis part of large convex aspheric surfaces. Secondly, optical wedges are simple to manufacture, do not require high-quality glass materials, and do not require coating on their surface. Thirdly, it can be verified that the single optical wedge compensation stitching method has good applicability, robustness and flexibility when testing large convex aspheric mirrors. Moreover, the full-aperture surface test accuracy of this method can reach 3.8 nmRMS, which meets the high-precision test requirements of large convex aspheric surfaces^[7].

However, the optical wedge compensation test is difficult to calibrate in practice. This is mainly be-

cause the beam is speckled after passing through the optical wedge, complicating the isolation and correction of systematic errors in the optical path using traditional methods. The main difficulty is the decoupling of the main error. Due to this, improving the calibration accuracy of single optical wedge compensation systems is key to improving the test reliability^[8].

Computer Generation Hologram (CGH) overcome the difficulty that optical holograms have reference entities. CGH can generate any form of wavefront, so it can be used to simulate the reflected wavefront of an ideal aspheric surface to calibrate the optical wedge compensator pose and eliminate systematic errors^[9-10]. CGH-based measurements were proposed in the 1970s and have gradually become a mature, high-precision optical test technology. For example, Burge^[11] used CGH to successfully test super-large aspheric surfaces. Zhou et al.^[12] divided the error induced by CGH used in the laboratory in two parts, distortion and manufacturing errors.

Zhao et al.^[13] combined the work of Zhou et al. to calibrate and separate CGH substrate error. They used this method to increase CGH accuracy to 6 nm.

Burge^[14] used a reflective CGH to calibrate the compensator to prevent immense economic losses caused by the compensator error. In China, CGH has usually been employed to test the surface of large aspheric optical elements and calibrate null compensators^[15-16]. For example, Zhu et al. calibrated a null-lens compensator using a tilted computer holographic plate^[17], and Chen et al. calibrated a zero compensator of a $\Phi 850$ mm F/2 parabolic primary mirror using CGH^[18]. The abovementioned examples show that CGH can be used to calibrate optical wedge compensators.

To solve the calibration problem of optical wedge compensators, a reflective CGH calibration method for an optical wedge compensator is proposed. In Sect.2, we first explains the source of error in single optical wedge compensation test optical path and analyzes the feasibility of using CGH calibration in a single optical wedge test system. In Sect.3, the design scheme of the CGH is introduced in detail, the source of CGH error is analysed, the calibration accuracy of the CGH is provided, and the test accuracy of the full-aperture surface shape after CGH calibration is analysed. In Sect.4, the calibration of the single wedge compensation test system error using the CGH is described.

2 Feasibility analysis of using CGH for calibrating single optical wedge compensation test system

2.1 Error source of the single optical wedge compensation test system

As shown in Fig. 1, the test result obtained by the interferometer is the superposition of the test wavefronts. This can be expressed as $W=W_a+W_N+w_m$, where W_N is a non-null error that can be obtained by simulations. $W_a=w_2-w_1=W_{TS}\oplus W_{OW}$ (\oplus is the coupling symbol), where W_{TS} is the system error of the transmission sphere, and W_{OW} is the systematic error introduced by a single optical wedge due to manufacturing and adjustment. When testing the subaperture of the same ring, W_a can be considered

as the system error. After calibration, W_a can be eliminated, thereby enabling the realization of error decoupling and obtaining the aspheric surface error, $w_m=w_4-w_3=W-W_a-W_N$.

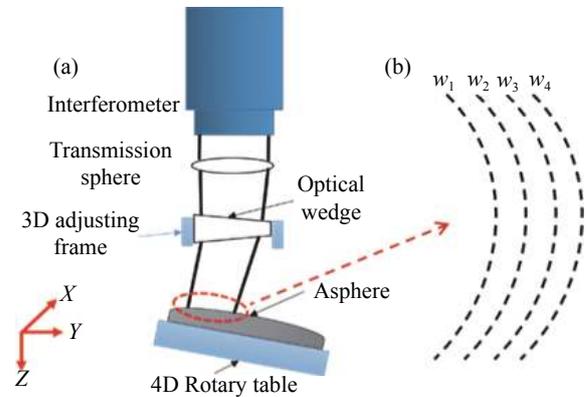


Fig. 1 (a) Single optical wedge test optical path. (b) Schematic of the test wavefront. w_1 , w_2 , w_3 , w_4 are theoretical incident wavefront, actual incident wavefront, theoretical aspheric surface and actual aspheric surface, respectively.

Based on engineering examples, a test scheme for single optical wedge compensation stitching is designed for large convex aspheric mirrors with a diameter of 425 mm^[7]. The subaperture planning and optical wedge design parameters are listed in Table 1. The optical wedge manufacturing error, the transmission sphere system error, and the non-null error of the test optical path are shown in Fig. 2 (Color online). To verify the feasibility of using CGH for calibrating the system error of a single optical wedge test path, a reflective CGH is designed for the single wedge compensator used in Tap#2.

Tab. 1 Basic parameters

Item	Tap#1	Tap#2	Tap#3
Number	1/21	8/21	12/21
Off-axis/mm	0	145	175
Sub-aperture planning			
Subaperture/mm	118	114	116
Departure/ μm	0.74	19.2	28.5
Need compensation	×	√	√
Diameter /mm		150	150
Centre thickness /mm		20	20
Optical wedge structure parameters			
Tilt/(°)		3.2	0.77
Wedge/(°)		6.3	6.3
Material		F_Silica	F_Silica

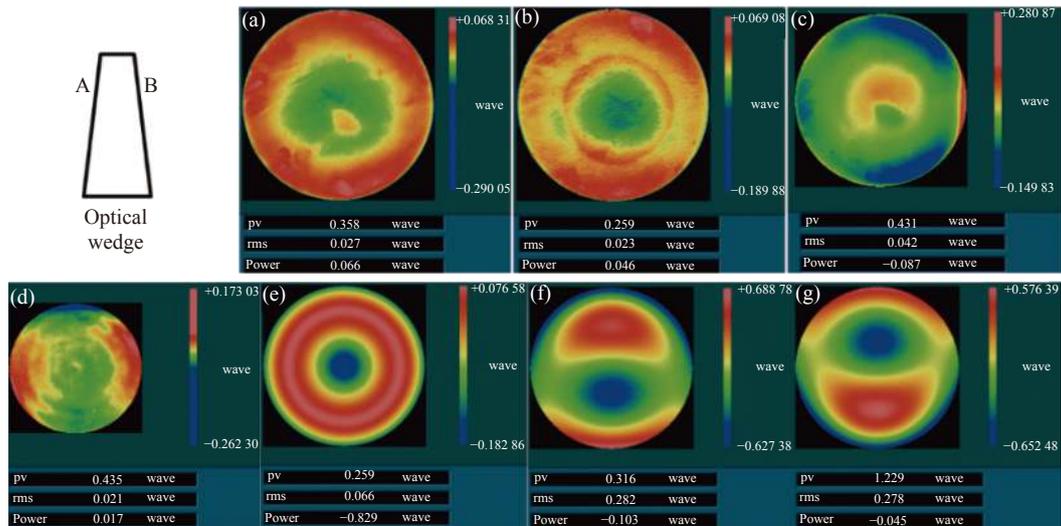


Fig. 2 (a) Surface shape of the optical wedge A. (b) Surface shape of optical wedge B. (c) Transmitted wave aberration. (d) Transmission sphere system error. (e) Tap#1 non-null error. (f) Tap#2 non-null error. (g) Tap#3 non-null error.

2.2 CGH calibration of the single optical wedge test path

The CGH calibrated single optical wedge compensation test optical path as shown in Fig. 3. The transmission sphere converts the parallel light emitted by the interferometer into a convergent spherical wave. This spherical wave is then transformed into an aspheric wave when the beam passes through the wedge compensator. The test mirror is replaced with the CGH. The light passing through the compensator illuminates the CGH and is completely reflected, returning to the interferometer along the original path. At this point, the CGH diffraction pattern is completely matched with the aspherical wave, forming a common test optical path, so that the pose and system errors of the optical wedge compensator can be calibrated out.

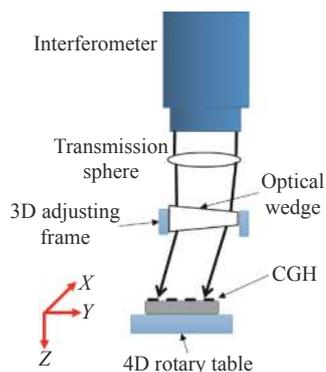


Fig. 3 Calibration of the single optical wedge test path

2.3 Sensitivity analysis of single optical wedge compensation test adjustment system

Combining the requirements of convex aspheric surface shape accuracy test (greater than $1/50\lambda$ RMS), and taking the wavefront change of 0.001λ as an example, the feasibility of CGH calibration of the optical wedge pose is analysed. The results are shown in Table 2. It can be seen that the accuracy of the CGH in calibrating the optical wedge pose is higher than the accuracy required for testing the optical wedge pose in the optical path. Therefore, after the single optical wedge compensator is calibrated, its pose accuracy can meet the measurement requirements.

Tab. 2 Adjustment tolerance analysis of the optical wedge compensator

	Wedge-interferometer dist./mm	Wedge-mirror dist./mm	x-tilt /($^{\circ}$)	y-tilt /($^{\circ}$)	Eccentric eccentricity /mm	RMS
Test system	0.15	0.15	0.005	0.01	3	$9.21 \times 10^{-3}\lambda$
Calibration system	0.05	0.05	0.0015	0.001	0.05	$8.35 \times 10^{-3}\lambda$

2.4 CGH fringe contrast analysis

Based on typical CGH diffraction efficiency, the diffraction efficiency of the CGH is analysed. The calculation formula is shown in Eq (1)^[19].

$$\eta_m = |A_m|^2 = \begin{cases} T_0^2(1-q)^2 + T_1^2q^2 + 2T_0T_1(1-q)\cos(\psi_{\text{etch}}), m = 0 \\ [T_0^2 + T_1^2 - 2T_0T_1(1-q)\cos(\psi_{\text{etch}})]q^2\text{sinc}^2[mq], m \neq 0 \end{cases} \quad (1)$$

Where T_0 and T_1 are the amplitude transmittance of the bright and dark fringes, respectively, ψ_{etch} is the phase difference, q denotes the duty cycle, and m is the diffraction order. $T_0=0$, $T_1=1$, $q=1/2$, $\psi_{\text{etch}}=0$.

For the amplitude in the CGH, the diffracted light intensity is 25% for the 0th order, 10.132% for the $\pm 1^{\text{st}}$ order, 1.126% for the $\pm 3^{\text{rd}}$ order and 0.405% for the $\pm 5^{\text{th}}$ order. For the phase of the CGH, there is theoretically no even diffraction order. The diffracted light intensity for the $\pm 1^{\text{st}}$ order is 40.528%, 4.503% for the $\pm 3^{\text{rd}}$ order and 1.621% for the $\pm 5^{\text{th}}$ order.

Assuming reference intensity $I_1 = 0.04$, outgoing light intensity

$$I_2 = 0.96 \times 0.96 \times \eta_m \times 0.96 \times 0.96,$$

interference light intensity

$$I_{\max} = I_1 + I_2 + 2\sqrt{I_1I_2}, \quad I_{\min} = I_1 + I_2 - 2\sqrt{I_1I_2},$$

and fringe contrast:

$$V = \frac{I_{\max} - I_{\min}}{I_{\max} + I_{\min}}. \quad (2)$$

The fringe contrast of each diffraction order of the CGH is obtained. The results are presented in Table 3.

Tab. 3 CGH fringe contrast

Diffraction order	Amplitude CGH	Phase CGH
0	73.05%	
± 1	93.09%	61.08%
± 3	78.92%	99.97%
± 5	54.01%	87.29%

It can be seen that both the amplitude and phase CGH design schemes meet the fringe contrast requirements. However, the amplitude CGH has a simpler process, the lowest error among alternatives and a higher accuracy. Therefore, we adopt the amplitude type CGH in this work.

3 CGH design plan

As shown in Fig.3, the CGH is used to replace the test mirror to calibrate the single optical wedge test optical path. Therefore, as shown in Fig. 4 (Color online), only the main area and alignment area need to be designed when designing the CGH.

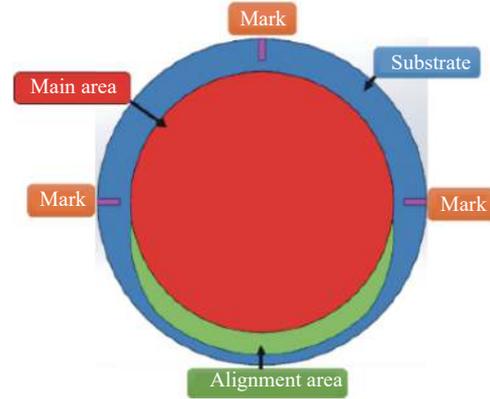


Fig. 4 Structure of the CGH

3.1 Design of the main area

The CGH main area is to calibrate the pose and system error of the optical wedge test system, which uses +1 as the main diffraction order. The design residual is shown in Fig. 5(a). As can be seen, the residual RMS is $1.77 \times 10^{-5} \lambda$, thereby meeting the design requirements. The diffraction energy level distribution of the multi-configuration is shown in Fig. 5(b). The distance between the +1st and 0th order diffraction spots is greater than 200 μm , meeting the requirement that the main diffraction order must be completely separated from the others. The diffraction pattern and setting parameter are shown in Fig.5(c) and Fig.5(b). The stripe line width is calculated using empirical equation (3):

$$l = \frac{D_{\text{aperture}}}{2 \cdot N \cdot n_{\text{cf}}}, \quad (3)$$

where D_{aperture} is the aperture of the CGH's main area, n_{cf} is equal to the value of the contour format and N represents the number of stripes. In this case, $D_{\text{aperture}}=119.52$ mm, $n_{\text{cf}}=1000$, $N=19$ and the stripe line width of the main area $l_{\text{main}}=3$ μm . This value meets the requirements of conventional CGH processing technology and can be processed and produced by laser direct writing and ion beam etching.

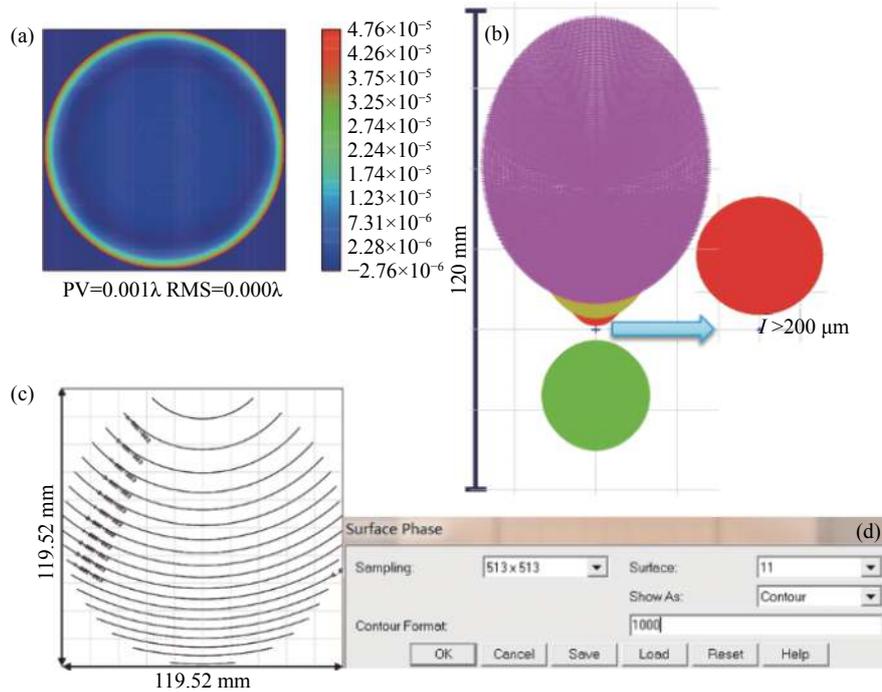


Fig. 5 Main area of the CGH. (a) Design residual; (b) diffraction order energy level distribution; (c) diffraction pattern; (d) surface phase setting parameters

3.2 Alignment area design

The CGH alignment area is used to align the relative position between the interferometer and the CGH, which used +3 as the main diffraction order. Fig 6 shows that the CGH alignment area appears as the green crescent-shaped structure in Fig. 4 due to the deflection introduced by the optical wedge.

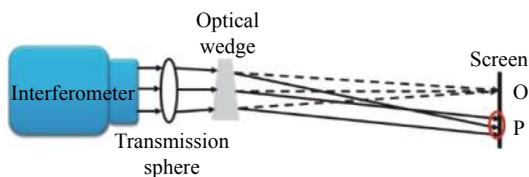


Fig. 6 Schematic of the single optical wedge deflection light path

The design residual is depicted in Fig. 7(a) (Color online). The residual RMS is $8.00 \times 10^{-6} \lambda$, thereby meeting the design requirements. The diffraction energy level distribution of the multi-configuration is depicted in Fig. 7(b) (Color online). The main diffraction order is completely separated from the other diffraction orders (Fig. 7(c)), eliminating the influence of the remaining diffraction orders on the main one. The width of the stripe line of the alignment area is obtained as $8 \mu\text{m}$ using Eq. (3). This also satisfies the requirements of conventional CGH processing technology and thus can be processed and produced by laser direct writing and ion beam etching.

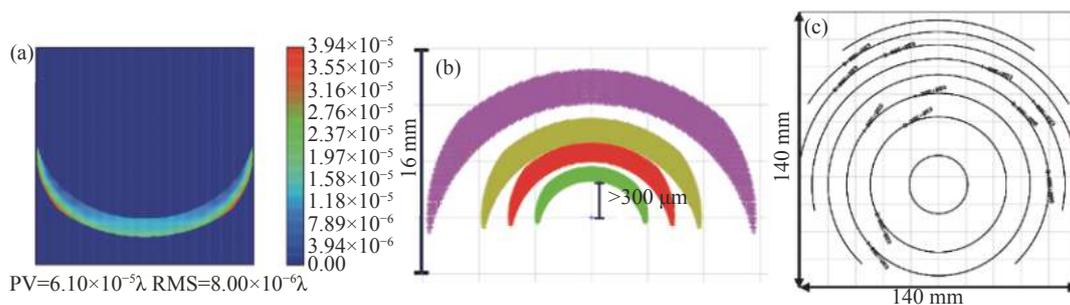


Fig. 7 Alignment area. (a) Design residual; (b) diffraction order energy level distribution; (c) diffraction pattern

3.3 CGH error analysis

An amplitude-type CGH is used in this study. When calculating CGH error sources, the main considerations are design residuals, coding errors, substrate errors and characteristic distortion^[20]. The CGH design residual is $1.77 \times 10^{-5} \lambda$, the actual coding error is $9.00 \times 10^{-4} \lambda$, and the substrate error test result is $3 \times 10^{-3} \lambda$, as shown in Fig. 8 (Color online). When creating the CGH, the CGH wavefront error caused by the positioning error of the laser direct writing instrument is the characterization distortion, of $1.57 \times 10^{-4} \lambda$. As presented in Table 4, the analysis of the abovementioned error resulted in a CGH calibration accuracy of $3.10 \times 10^{-3} \lambda$ RMS (1.98 nm).

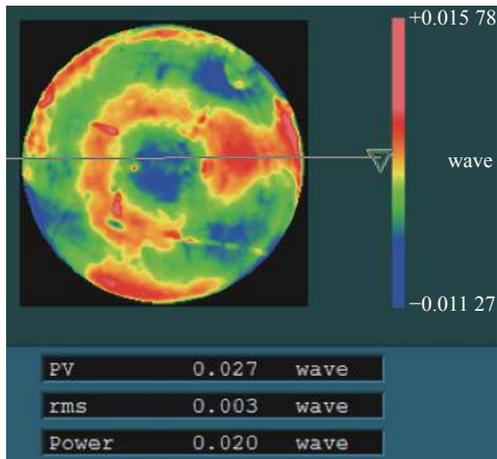


Fig. 8 Substrate error

The test accuracy of single optical wedge compensation under CGH calibration is also analysed. The random noise in Table 5 can be obtained by averaging multiple measurements. Fig. 9 (Color on-

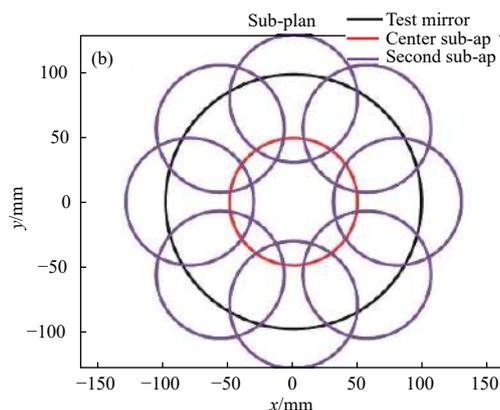
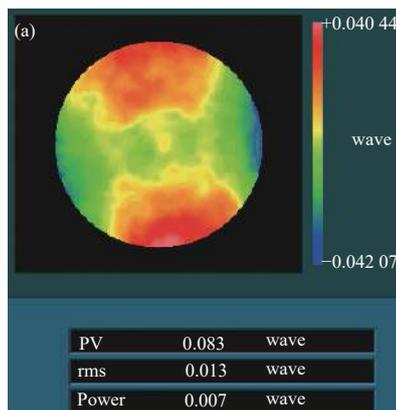
line) shows the test results of a convex spherical surface with a diameter of 197 mm using the stitching algorithm in this paper. From Fig. 9(d), the stitching algorithm can be obtained as 0.002λ RMS (1.26 nm). As presented in Table 5, the analysis showed that the accuracy of the single optical wedge compensation test after CGH calibration is 3.43 nm RMS, thereby meeting the requirements of calibrating large convex aspheric surfaces. The results showed that CGH can be used to calibrate the pose and system error of a single optical wedge compensator and to improve the accuracy and reliability of the single optical wedge compensation test method.

Tab. 4 CGH error

Error type	Value
design residual	$1.77 \times 10^{-5} \lambda$
coding error	$9.00 \times 10^{-4} \lambda$
substrate error	$3.00 \times 10^{-3} \lambda$
characterization distortion	$1.57 \times 10^{-4} \lambda$
RMS	$3.10 \times 10^{-3} \lambda$

Tab. 5 Single optical wedge compensation test accuracy after CGH calibration (nm)

Error	Value
Measuring random error	2.5
CGH calibration test optical path system error	1.98
Accuracy of stitching algorithm	1.26
RMS	3.43



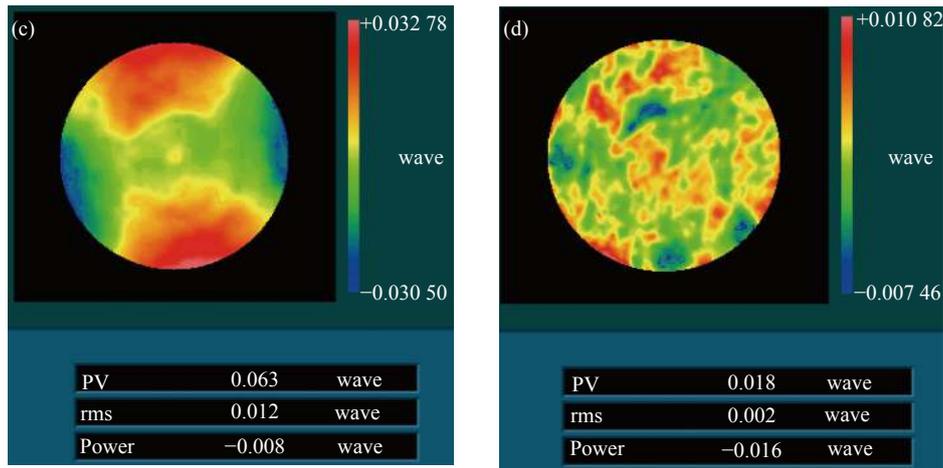


Fig. 9 Convex spherical stitching test result ($D = 197$ mm) (a) Actual full-aperture surface; (b) sub-plane; (c) stitching test result; (d) the residual difference between the stitching test result and the full-aperture surface result

4 CGH calibration test system's error

After analysis, the CGH is used to calibrate the actual single optical wedge compensation test optical path. The test optical path is depicted in Fig. 10. Firstly, the position of CGH on the turntable was determined. The mark in the X direction on the CGH was parallel to the X direction of the turntable, and the mark in the Y direction on the CGH was coincide with the Y axis of the turntable. Then, the CGH along the Y axis was moved to the design position.

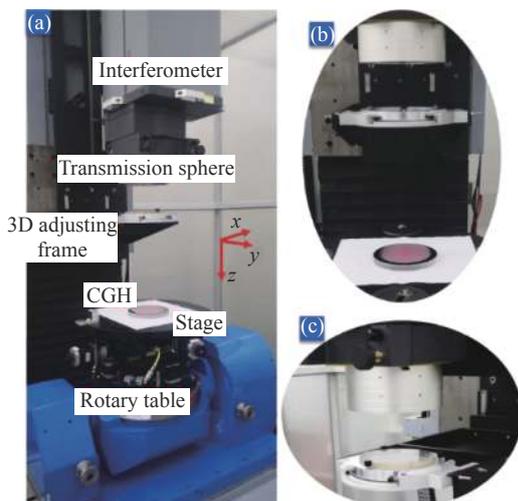


Fig. 10 (a) Calibration optical path diagram of optical wedge compensator. (b) CGH and interferometer aligned on the optical path. (c) Insertion of the optical wedge compensator

After the CGH position was determined, the CGH alignment area was used to align the position between the interferometer and CGH, as depicted in Fig. 9(b). The alignment area test results are shown in Fig. 10(a) and Fig. 10(c). Eq(4) is used to calculate the defocus ε_z between the CGH and interferometer on the Z -axis to determine whether the alignment between the interferometer and the CGH is complete. Here, $F^\# = 13$ and $\Delta W_{\text{defocus}}$ represent the Peak-to-Valley(PV) in the test result. Taking Fig. 10(a) as an example, the defocus ε_z between the focal point of the CGH and the focal point of the interferometer is obtained as $\varepsilon_z = 0.056$ mm. This distance meets the adjustment requirement of the test mirror; therefore, the alignment between the interferometer and the CGH was complete.

$$\Delta W_{\text{defocus}} = \pm \frac{\varepsilon_z}{8(F^\#)^2} \quad (4)$$

After alignment, we calibrated the single wedge compensator, as shown in Fig. 11 (Color on-line). The calibration error results of Tap#2 (Fig. 11(b)), and Tap#2 (Fig. 11(d)) are $0.023\lambda\text{RMS}$ and $0.011\lambda\text{RMS}$, respectively. When the single optical wedge stitching is used to test the full-aperture surface, the system error obtained by calibration can be eliminated. Therefore, the accuracy and credibility of the single optical wedge compensation test is improved.

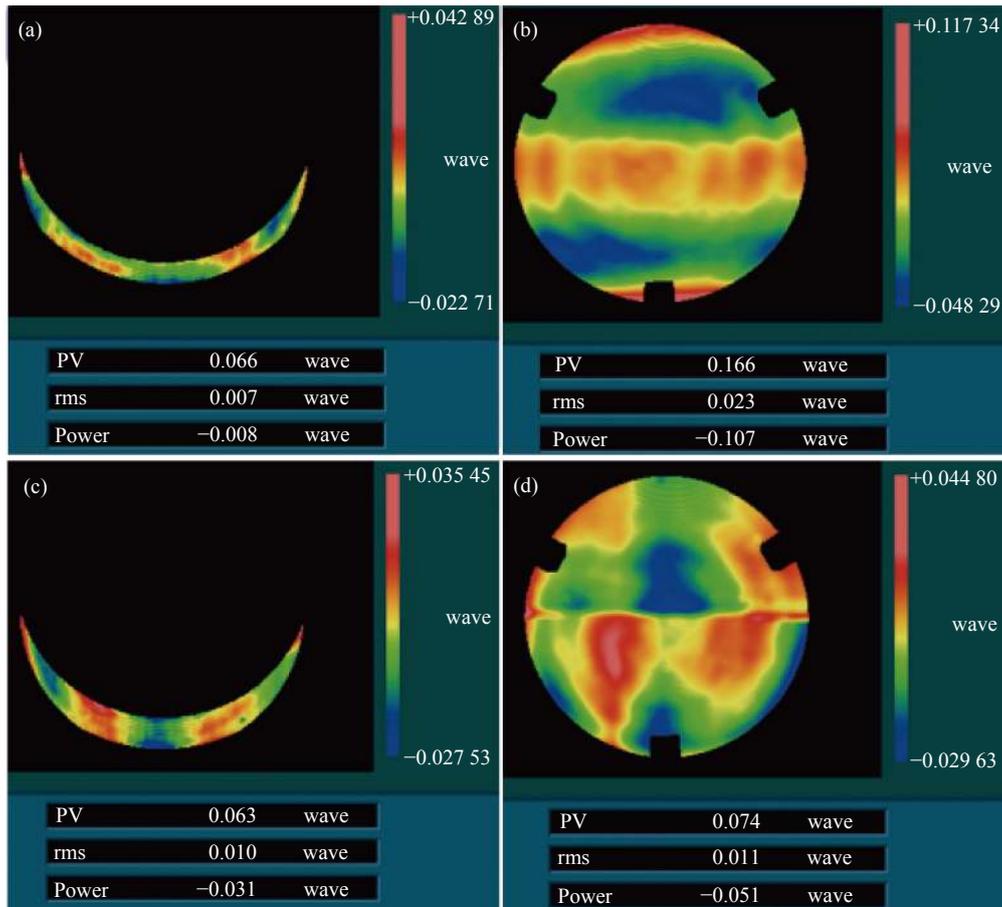


Fig. 11 Calibration results for the test path system error. (a) CGH alignment result by Tap#2. (b) Test path system error by Tap#2. (c) CGH alignment result by Tap#3. (d) Test path system error by Tap#3

5 Conclusion

A method that uses reflective CGH calibration for a single optical wedge error test compensation system is proposed. The method decouples the errors in the test results of single optical wedge compensation. The feasibility of the method is verified through analysis of the CGH principle, fringe contrast, and the sensitivity of the single wedge compensator in testing and adjusting the optical path.

In addition, a reflective CGH calibration experiment is designed for the single optical wedge test optical path to test large convex aspheric mirrors with a diameter of 425 mm. The CGH calibration

accuracy is 1.98 nmRMS. After CGH calibration, the test accuracy of the full surface of single wedge compensation is 3.43 nmRMS, thereby meeting the calibration requirements of single optical test optical paths for system errors. We also obtained systematic errors at two Tap of 0.023λ and 0.011λ after CGH calibration.

The analysis and experimental results show that the reflective CGH calibration method can accurately calibrate the single optical wedge compensation test path, including both the system error and pose, thereby improving the test accuracy and credibility of the single optical wedge compensation method.

References:

- [1] 黎发志, 郑立功, 闫锋, 等. 自由曲面的CGH光学检测方法实验[J]. *红外与激光工程*, 2012, 41(4): 1052-1056.

- LI F ZH, ZHENG L G, YAN F, *et al.*. Optical testing method and its experiment on freeform surface with computer-generated hologram[J]. *Infrared and Laser Engineering*, 2012, 41(4): 1052-1056. (in Chinese)
- [2] 任建锋, 郭培基. 计算全息法检测离轴凸非球面照明镜组初始结构设计[J]. *光学学报*, 2012, 32(2): 0222005.
- REN J F, GUO P J. Design of original structure of illuminating system in off-axis convex aspherical lens testing system with computer-generated hologram[J]. *Acta Optica Sinica*, 2012, 32(2): 0222005. (in Chinese)
- [3] 王孝坤, 王丽辉, 邓伟杰, 等. 用非零位补偿法检测大口径非球面反射镜[J]. *光学精密工程*, 2011, 19(3): 520-528.
- WANG X K, WANG L H, DENG W J, *et al.*. Measurement of large aspheric mirrors by non-null testing[J]. *Optics and Precision Engineering*, 2011, 19(3): 520-528. (in Chinese)
- [4] ZHANG L, TIAN CH, LIU D, *et al.*. Non-null annular subaperture stitching interferometry for steep aspheric measurement[J]. *Applied Optics*, 2014, 53(25): 5755-5762.
- [5] ZHANG L, LI D, LIU Y, *et al.*. Validation of simultaneous reverse optimization reconstruction algorithm in a practical circular subaperture stitching interferometer[J]. *Optics Communications*, 2017, 403: 41-49.
- [6] SUPRANOWITZ C, MCFEE C, MURPHY P. Asphere metrology using variable optical null technology[J]. *Proceedings of SPIE*, 2012, 8416: 841604.
- [7] CAI ZH H, WANG X K, HU H X, *et al.*. Testing large convex aspheres using a single wedge compensation and stitching method[J]. *Optics Communications*, 2021, 480: 126484.
- [8] TRICARD M, KULAWIEC A, BAUER M, *et al.*. Subaperture stitching interferometry of high-departure aspheres by incorporating a variable optical null[J]. *CIRP Annals*, 2010, 59(1): 547-550.
- [9] HE Y W, HOU X, WU F, *et al.*. Analysis of spurious diffraction orders of computer-generated hologram in symmetric aspheric metrology[J]. *Optics Express*, 2017, 25(17): 20556-20572.
- [10] ZHANG H D, WANG X K, XUE D L, *et al.*. Modified surface testing method for large convex aspheric surfaces based on diffraction optics[J]. *Applied Optics*, 2017, 56(34): 9398-9405.
- [11] BURGE J H, KOT L B, MARTIN H M, *et al.*. Design and analysis for interferometric measurements of the GMT primary mirror segments[J]. *Proceedings of SPIE*, 2006, 6273: 62730M.
- [12] ZHOU P, BURGE J H. Fabrication error analysis and experimental demonstration for computer-generated holograms[J]. *Applied Optics*, 2007, 46(5): 657-663.
- [13] ZHAO CH Y, BURGE J H. Optical testing with computer generated holograms: comprehensive error analysis[J]. *Proceedings of SPIE*, 2013, 8838: 88380H.
- [14] BURGE J H. Null test for null correctors: error analysis[J]. *Proceedings of SPIE*, 1993, 1993: 86-97.
- [15] 张海东, 王孝坤, 薛栋林, 等. 一种针对超大口径凸非球面的面形检测方法[J]. *中国光学*, 2019, 12(5): 1147-1154.
- ZHANG H D, WANG X K, XUE D L, *et al.*. Surface testing method for ultra-large convex aspheric surfaces[J]. *Chinese Optics*, 2019, 12(5): 1147-1154. (in Chinese)
- [16] 李明, 罗霄, 薛栋林, 等. 考虑投影畸变设计大口径离轴非球面检测用计算全息图[J]. *光学精密工程*, 2015, 23(5): 1246-1253.
- LI M, LUO X, XUE D L, *et al.*. Design of CGH for testing large off-axis asphere by considering mapping distortion[J]. *Optics and Precision Engineering*, 2015, 23(5): 1246-1253. (in Chinese)
- [17] 朱德燕, 李明, 薛栋林, 等. 倾斜计算全息板标定补偿器误差[J]. *光学学报*, 2015, 35(4): 0412001.
- ZHU D Y, LI M, XUE D L, *et al.*. Absolute testing of null lens errors with tilted computer-generated-hologram[J]. *Acta Optica Sinica*, 2015, 35(4): 0412001. (in Chinese)
- [18] 陈强, 伍凡, 袁家虎, 等. 用计算全息标校补偿器的技术[J]. *光学学报*, 2007, 27(12): 2175-2178.
- CHEN Q, WU F, YUAN J H, *et al.*. Certification of compensator by computer-generated hologram[J]. *Acta Optica Sinica*, 2007, 27(12): 2175-2178. (in Chinese)
- [19] LI M, ZHANG X J. Test of large off-axis aspheric surface with CGH[C]. *CIOMP-OSA Summer Session on Optical Engineering, Design and Manufacturing*, Optical Society of America. 2013.
- [20] BURGE J H, ZHAO CH Y, DUBIN M. Measurement of aspheric mirror segments using Fizeau interferometry with CGH correction[J]. *Proceedings of SPIE*, 2010, 7739: 773902.

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